

# N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (Typ.)			
100	0.124 at V <sub>GS</sub> = 10 V	4.2	4.6 nC			
100	0.128 at $V_{GS}$ = 4.5 V	3.9	4.0 110			

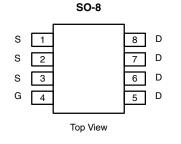
#### **FEATURES**

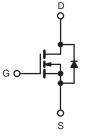
- Trench Power MOSFET
- 100 % UIS Tested

## APPLICATIONS

- High Frequency Boost Converter
- LED Backlight for LCD TV







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25 °C, unless otherwise noted)						
Parameter	Symbol	Limit	Unit			
Drain-Source Voltage		V <sub>DS</sub>	100	V		
Gate-Source Voltage		V <sub>GS</sub>	± 20			
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	- I <sub>D</sub> -	4.2 3.5 3.0 <sup>a, b</sup> 2.4 <sup>a, b</sup>	A		
Pulsed Drain Current		I <sub>DM</sub>	16			
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C T <sub>A</sub> = 25 °C	- I <sub>S</sub> -	4.0 2 <sup>a, b</sup>			
Single Avalanche Current	Avalanche Current L = 0.1 mH		6	A		
Single Avalanche Energy		E <sub>AS</sub>	1.8	mJ		
Maximum Power Dissipation $\begin{array}{c} T_{C} = 25\\ T_{C} = 70\\ T_{A} = 25\\ T_{A} = 70\\ T_{A} = 70\\ T_{C} = 7$		P <sub>D</sub>	4.8 3 2.4 <sup>a, b</sup> 1.5 <sup>a, b</sup>	w		
Operating Junction and Storage Temperatur	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	O°			

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>a, c</sup>	t ≤ 10 s	R <sub>thJA</sub>	42	53	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	21	26	C/W	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Maximum under steady state conditions is 85  $^\circ\text{C/W}.$ 

d. Based on T\_C = 25 °C.

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			T		[	r	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V$ , $I_D = 250 \mu A$	100			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		110		- mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	_ `		- 7.5			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0$ V, $V_{GS} = \pm 20$ V			± 100	nA	
Zero Gate Voltage Drain Current	1	$V_{DS} = 100 V, V_{GS} = 0 V$			1		
Zero Gale voltage Drain Current	$\frac{V_{DSS}}{V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}}$			10	μΑ		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5$ V, $V_{GS}$ = 10 V	8			Α	
	5	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 2.7 \text{ A}$		0.124			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_{D} = 2.5 \text{ A}$		0.128		Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 2.7 A		7		S	
Dynamic <sup>b</sup>						<u> </u>	
Input Capacitance	C <sub>iss</sub>			470		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V, f = 1 MHz		50			
Reverse Transfer Capacitance	C <sub>rss</sub>			25			
-		$P_{Q_g}$ $V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_D = 2.7 \text{ A}$		7.1	11		
Total Gate Charge	Qg			4.6	7		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 6 \text{ V}, I_{D} = 2.7 \text{ A}$		1.7		nC	
Gate-Drain Charge	Q <sub>gd</sub>			2			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		3		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			10	15		
Rise Time	tr	$V_{DD} = 50 \text{ V}, \text{ R}_{\text{I}} = 23.8 \Omega$		10	15	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 2.1 \text{ A}, \text{ V}_{\text{GEN}} = 6 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		10	15		
Fall Time	t <sub>f</sub>	5		10	15		
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 50 V, $R_L$ = 23.8 $\Omega$		10	15	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 2.1 \text{ A}, V_{GEN} = 10 \text{ V}, \text{ R}_q = 1 \Omega$		12	20		
Fall Time	t <sub>f</sub>			10	15		
Drain-Source Body Diode Characteristi	-			1			
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			4		
Pulse Diode Forward Current	I <sub>SM</sub>	5			8	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 2.1 A, V <sub>GS</sub> = 0 V		0.8	1.2	v	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	3 / 00		50	80	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			75	120	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F$ = 2.1 A, dl/dt = 100 A/µs, $T_J$ = 25 °C		28	120		
Reverse Recovery Rise Time						ns	
Reverse Recovery Rise Time	t <sub>b</sub>			22			

Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %

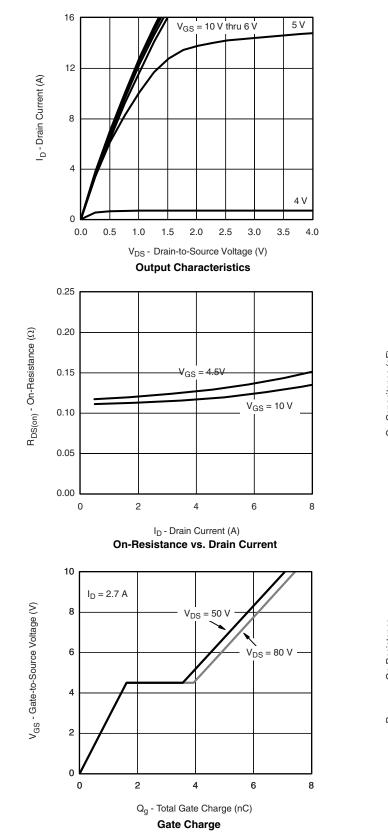
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

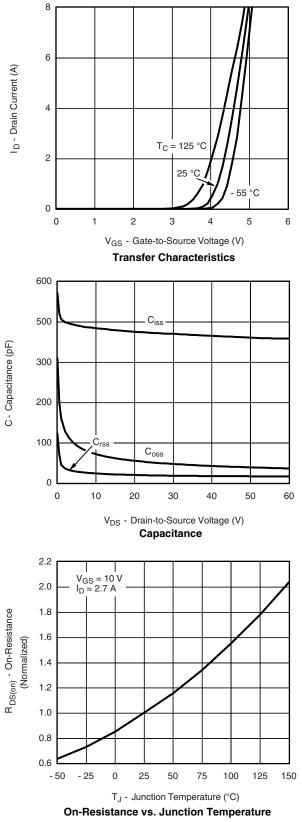
semi

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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





8

100

10

1

Time (s) Single Pulse Power 1000

10

 $I_{D} = 2.7 \text{ A}$ 

2

4

0.1

100 ms

s

10 s

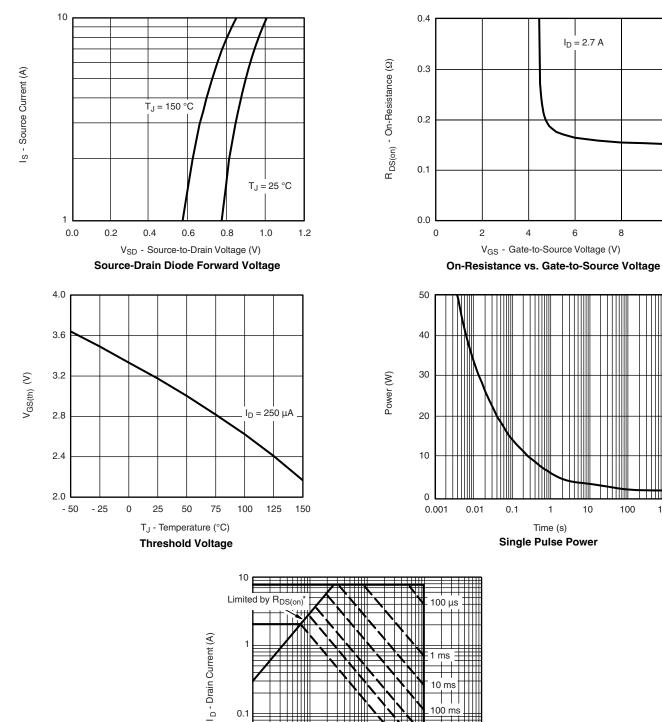
DC

1000

100

V<sub>GS</sub> - Gate-to-Source Voltage (V)

6



0.1

0.01 0.1

T<sub>A</sub> = 25 °C Single Pulse

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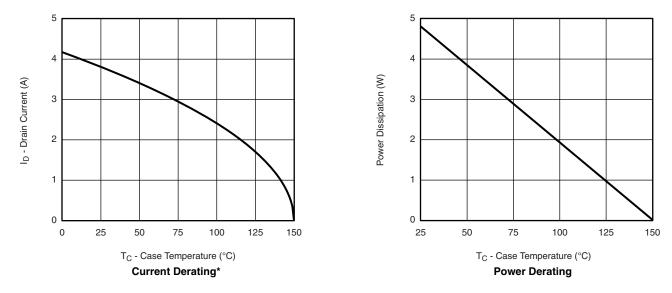
V<sub>DS</sub> - Drain-to-Source Voltage (V) \*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified Safe Operating Area, Junction-to-Ambient

#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





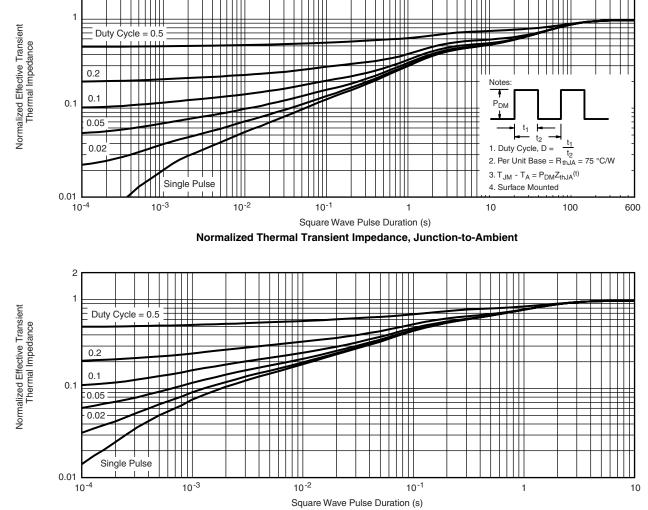
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

2





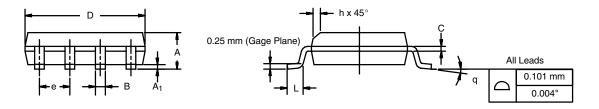
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Foot



# SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012

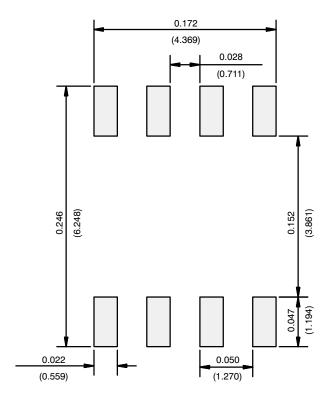




	MILLIM	IETERS	INC	HES	
DIM	Min	Мах	Min	Max	
A	1.35	1.75	0.053	0.069	
A <sub>1</sub>	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



**RECOMMENDED MINIMUM PADS FOR SO-8** 



Recommended Minimum Pads Dimensions in Inches/(mm)



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